Product data sheet

1. General description

Planar passivated Silicon Controlled Rectifier in a TO247 Plus plastic package intended for use in applications requiring very high inrush current capability and high thermal cycling performance

2. Features and benefits

- High junction operating temperature capability (T_{i(max)} = 150 °C)
- Very high current surge capability
- · Planar passivated for voltage ruggedness and reliability
- · High thermal cycling performance
- High voltage capability

3. Applications

- Line rectifying 50/60 Hz
- · Softstart AC motor control
- DC Motor control
- Power converter
- AC power control
- · Lighting and temperature control
- Uninterruptible Power Supply (UPS)
- Solid State Relay (SSR)
- Traction battery charging

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes		Values		Unit
V_{DRM}	repetitive peak off-state voltage			1600			V
I _{T(RMS)}	RMS on-state current	half sine wave; T _{mb} ≤ 97 °C; <u>Fig. 1; Fig. 2; Fig. 3</u>		250			А
I _{TSM}	non-repetitive peak on- state current	half sine wave; $T_{j(init)} = 25$ °C; $t_p = 10$ ms; Fig. 4; Fig. 5		1600			А
		half sine wave; $T_{j(init)}$ = 25 °C; t_p = 8.3 ms			1760		Α
T _j	operating junction temperature				-40 to 15	0	°C
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static ch	aracteristics						
I _{GT}	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.2 \text{ A}; T_j = 25 \text{ °C};$ Fig. 7		15	-	100	mA
I _H	holding current	V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u>		-	-	200	mA
V _T	on-state voltage	I _T = 160 A; T _j = 25 °C; <u>Fig. 11</u>		-	-	1.50	V
Dynamic characteristics							
dV _D /dt	rate of rise of off-state voltage	V_{DM} = 1072 V; (V_{DM} = 67% of V_{DRM}); exponential waveform; gate open circuit; T_j = 150 °C		1500	-	-	V/µs

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	K	cathode		
2	А	anode		A 🕌 K G
3	G	gate		sym037
mb	A	mounting base; connected to anode	1 2 3	

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
TYN160WP-1600T	TO247P	TYN160WP-1600TQ	Tube	30	TO247PN	25-Jun-2024

7. Marking

Table 4. Marking codes

Type number	Marking codes
TYN160WP-1600T	TYN160WP
	1600T

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
V_{DRM}	repetitive peak off-state voltage			1600	V
V_{RRM}	repetitive peak reverse voltage			1600	V
I _{T(AV)}	average on-state current	half sine wave; T _{mb} ≤ 97 °C;		160	А
I _{T(RMS)}	RMS on-state current	half sine wave; $T_{mb} \le 97$ °C; Fig. 1; Fig. 2; Fig. 3		250	А
I _{TSM}	non-repetitive peak on- state current	half sine wave; $T_{j(init)}$ = 25 °C; t_p = 10 ms; Fig. 4; Fig. 5		1600	А
		half sine wave; $T_{j(init)}$ = 25 °C; t_p = 8.3 ms		1760	Α
l ² t	I ² t for fusing	t _p = 10 ms; sine-wave pulse		12800	A ² s
dl _⊤ /dt	rate of rise of on-state current	I _G = 200 mA		200	A/µs
I _{GM}	peak gate current			10	А
V_{GRM}	peak reverse gate voltage			5	V
P _{GM}	peak gate power			20	W
$P_{G(AV)}$	average gate power	over any 20 ms period		0.5	W
T _{stg}	storage temperature			-40 to 150	°C
T _j	operating junction temperature			-40 to 150	°C

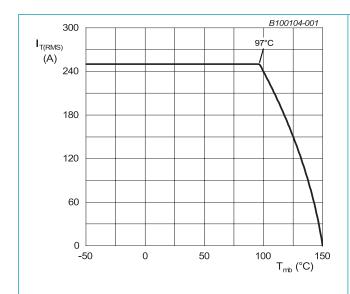
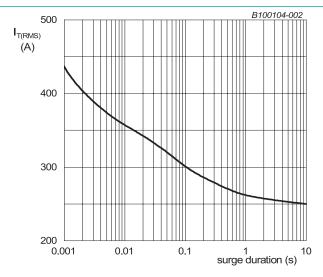
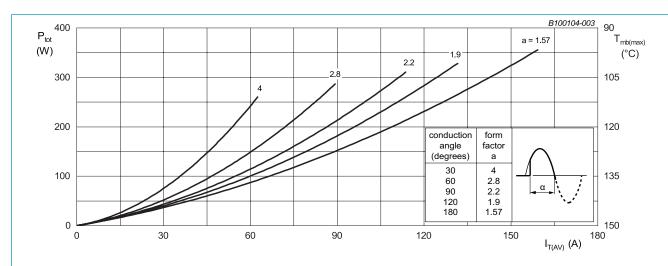


Fig. 1. RMS on-state current as a function of mounting base temperature; maximum values



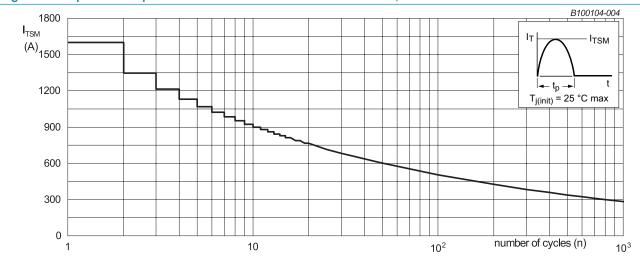
f = 50 Hz; T_{mb} = 97 °C Fig. 2. RMS on-state current as a function of surge duration; maximum values



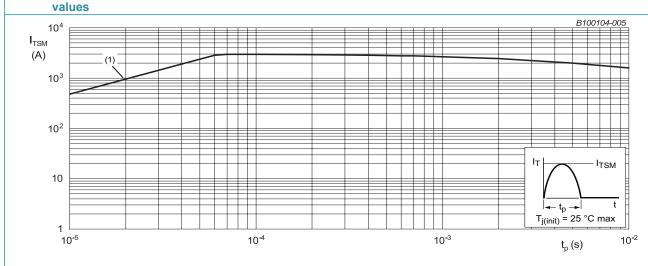
 α = conduction angle

a = form factor = $I_{T(RMS)}/I_{T(AV)}$

Fig. 3. Total power dissipation as a function of RMS on-state current; maximum values



f = 50 Hz
Fig. 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum



 $t_p \le 10 \text{ ms}$

(1) dl_T/dt limit

Fig. 5. Non-repetitive peak on-state current as a function of pulse duration; maximum values

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
$R_{\text{th(j-mb)}}$	thermal resistance from junction to mounting base	Fig. 6		-	-	0.15	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	in free air		-	45	-	K/W

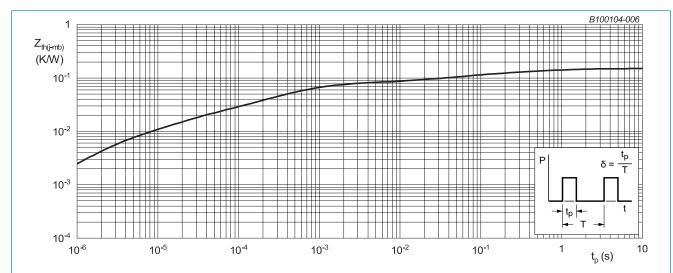
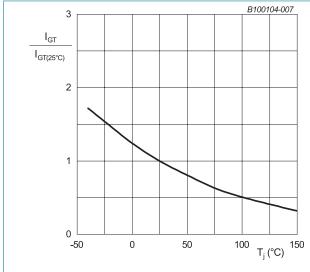


Fig. 6. Transient thermal impedance from junction to mounting base as a function of pulse duration; maximum values

10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	aracteristics						
I _{GT}	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.2 \text{ A}; T_j = 25 \text{ °C};$ Fig. 7		15	-	100	mA
I _L	latching current	$V_D = 12 \text{ V}; I_G = 0.2 \text{ A}; T_j = 25 \text{ °C}; Fig. 8$		-	-	300	mA
I _H	holding current	V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u>		-	-	200	mA
V _T	on-state voltage	I _T = 160 A; T _j = 25 °C; <u>Fig. 11</u>		-	-	1.50	V
V _{GT} g	gate trigger voltage	V _D = 12 V; I _T = 0.2 A; T _j = 25 °C; <u>Fig. 10</u>		-	0.7	2.0	V
		V _D = 1600 V; I _T = 0.2 A; T _j = 150 °C		0.25	0.45	-	V
I _D	off-state current	V _D = 1600 V; T _j = 25 °C		-	-	100	μA
		V _D = 1600 V; T _j = 150 °C		-	-	15	mA
I _R	reverse current	V _D = 1600 V; T _j = 25 °C		-	-	100	μA
		V _D = 1600 V; T _j = 150 °C		-	-	15	mA
Dynamic	characteristics						
dV _D /dt	rate of rise of off-state voltage	V_{DM} = 1072 V; (V_{DM} = 67% of V_{DRM}); exponential waveform; gate open circuit; T_j = 150 °C		1500	-	-	V/µs
t _{gt}	gate-controlled turn-on time	$I_{TM} = 50 \text{ A}; V_D = 800 \text{ V}; I_G = 0.2 \text{ A};$ $dI_G/dt = 5 \text{ A}/\mu\text{s}; T_j = 25 \text{ °C}$		-	2	-	μs
t _q	commutated turn-off time	$V_{DM} = 1072 \text{ V}; (V_{DM} = 67\% \text{ of } V_{DRM});$ $I_{TM} = 160 \text{ A}; V_{R} = 25 \text{ V}; (d_{IT}/d_{I})M = 30 \text{ A/}\mu\text{s};$ $dV_{D}/dt = 50 \text{ V/}\mu\text{s}; R_{GK(ext)} = 100 \text{ k}\Omega;$ $T_{i} = 125 \text{ °C}$		-	150	-	μs



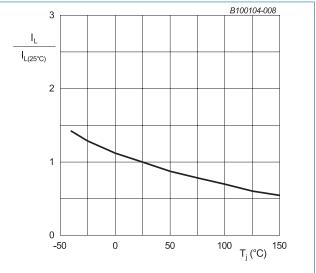
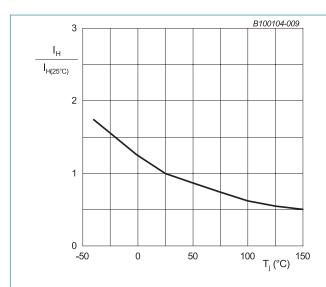


Fig. 7. Normalized gate trigger current as a function of junction temperature

Fig. 8. Normalized latching current as a function of junction temperature

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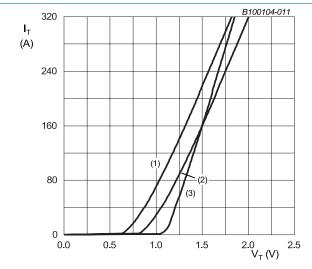


 $V_{\rm GT}$ V_{GT(25°C)} 1.2 8.0 0.4 T_j (°C) 150 -50 0 50 100

1.6

Fig. 9. Normalized holding current as a function of junction temperature

Fig. 10. Normalized gate trigger voltage as a function of junction temperature



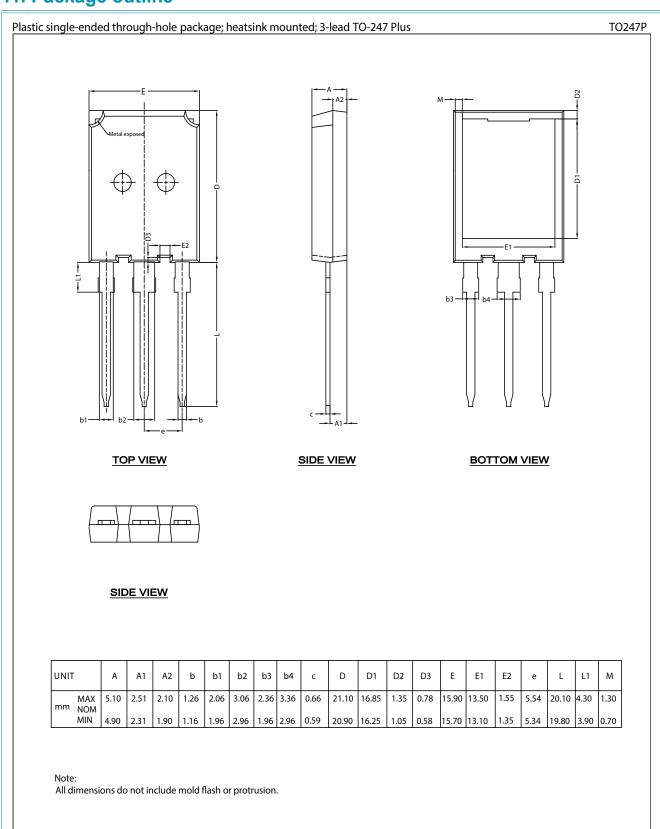
 V_o = 0.986 V; R_s = 0.0032 Ω (1) T_j = 150 °C; typical values

(2) T_i = 150 °C; maximum values

(3) $T_i = 25$ °C; maximum values

Fig. 11. On-state current as a function of on-state voltage

11. Package outline



12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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